

Features

- Super Low Gate Charge
- 100% EAS Guaranteed
- Excellent CdV/dt effect decline
- Green Device Available
- Advanced high cell density Trench technology

Product Summary

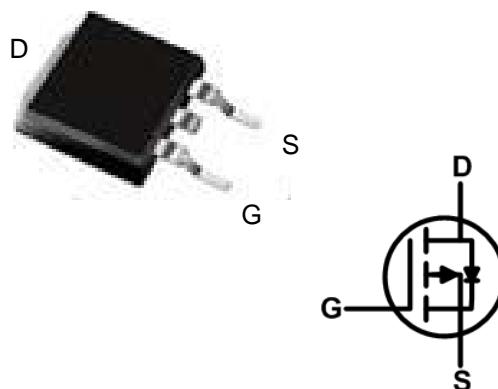
| BVDSS | RDS(on) | ID |
|-------|---------|------|
| -40V | 13mΩ | -52A |

Description

The D52P04M is the high cell density trenched P-ch MOSFETs, which provide excellent RDS(on) and gate charge for most of the synchronous buck converter applications.

The D52P04M meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

TO-252 Pin Configuration



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|---------------------------------------|---|------------|-------|
| V _{DS} | Drain-Source Voltage | -40 | V |
| V _{GS} | Gate-Source Voltage | ±20 | V |
| I _D @T _C =25°C | Continuous Drain Current, V _{GS} @ -10V ¹ | -52 | A |
| I _D @T _C =100°C | Continuous Drain Current, V _{GS} @ -10V ¹ | -32 | A |
| I _D @T _A =25°C | Continuous Drain Current, V _{GS} @ -10V ¹ | -10 | A |
| I _D @T _A =70°C | Continuous Drain Current, V _{GS} @ -10V ¹ | -8 | A |
| I _{DM} | Pulsed Drain Current ² | -105 | A |
| EAS | Single Pulse Avalanche Energy ³ | 146 | mJ |
| I _{AS} | Avalanche Current | -54 | A |
| P _D @T _C =25°C | Total Power Dissipation ⁴ | 52.1 | W |
| P _D @T _A =25°C | Total Power Dissipation ⁴ | 2 | W |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|------------------|--|------|------|------|
| R _{θJA} | Thermal Resistance Junction-Ambient ¹ | --- | 62 | °C/W |
| R _{θJC} | Thermal Resistance Junction-Case ¹ | --- | 2.4 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--|--|--|------|--------|-----------|----------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{\text{GS}}=0\text{V}$, $I_D=-250\mu\text{A}$ | -40 | --- | --- | V |
| $\Delta \text{BV}_{\text{DSS}}/\Delta T_J$ | BV_{DSS} Temperature Coefficient | Reference to 25°C , $I_D=-1\text{mA}$ | --- | -0.023 | --- | $\text{V}/^\circ\text{C}$ |
| $R_{\text{DS}(\text{ON})}$ | Static Drain-Source On-Resistance ² | $V_{\text{GS}}=-10\text{V}$, $I_D=-18\text{A}$ | --- | 10.5 | 13 | $\text{m}\Omega$ |
| | | $V_{\text{GS}}=-4.5\text{V}$, $I_D=-12\text{A}$ | --- | 15 | 20 | |
| $V_{\text{GS}(\text{th})}$ | Gate Threshold Voltage | $V_{\text{GS}}=V_{\text{DS}}$, $I_D=-250\mu\text{A}$ | -1.0 | -1.6 | -2.5 | V |
| $\Delta V_{\text{GS}(\text{th})}$ | $V_{\text{GS}(\text{th})}$ Temperature Coefficient | | --- | 4.74 | --- | $\text{mV}/^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{\text{DS}}=-32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$ | --- | --- | 1 | uA |
| | | $V_{\text{DS}}=-32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=55^\circ\text{C}$ | --- | --- | 5 | |
| I_{GSS} | Gate-Source Leakage Current | $V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$ | --- | --- | ± 100 | nA |
| g_{fs} | Forward Transconductance | $V_{\text{DS}}=-5\text{V}$, $I_D=-18\text{A}$ | --- | 24 | --- | S |
| R_g | Gate Resistance | $V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$ | --- | 7 | 14 | Ω |
| Q_g | Total Gate Charge (-4.5V) | $V_{\text{DS}}=-20\text{V}$, $V_{\text{GS}}=-4.5\text{V}$, $I_D=-12\text{A}$ | --- | 27.9 | --- | nC |
| Q_{gs} | Gate-Source Charge | | --- | 7.7 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 7.5 | --- | |
| $T_{\text{d}(\text{on})}$ | Turn-On Delay Time | $V_{\text{DD}}=-15\text{V}$, $V_{\text{GS}}=-10\text{V}$, $R_G=3.3\Omega$, $I_D=-1\text{A}$ | --- | 40 | --- | ns |
| T_r | Rise Time | | --- | 35.2 | --- | |
| $T_{\text{d}(\text{off})}$ | Turn-Off Delay Time | | --- | 100 | --- | |
| T_f | Fall Time | | --- | 9.6 | --- | |
| C_{iss} | Input Capacitance | $V_{\text{DS}}=-15\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$ | --- | 3500 | --- | pF |
| C_{oss} | Output Capacitance | | --- | 323 | --- | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 222 | --- | |
| Diode Characteristics | | | | | | |
| I_s | Continuous Source Current ^{1,5} | $V_G=V_D=0\text{V}$, Force Current | --- | --- | -52 | A |
| I_{SM} | Pulsed Source Current ^{2,5} | | --- | --- | -105 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{\text{GS}}=0\text{V}$, $I_s=-1\text{A}$, $T_J=25^\circ\text{C}$ | --- | --- | -1 | V |

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{\text{DD}}=-25\text{V}$, $V_{\text{GS}}=-10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=-54\text{A}$
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_s , in real applications , should be limited by total power dissipation.

Typical Characteristics

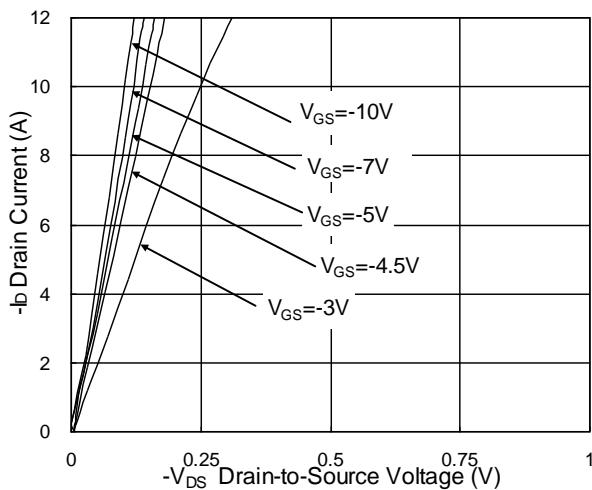


Fig.1 Typical Output Characteristics

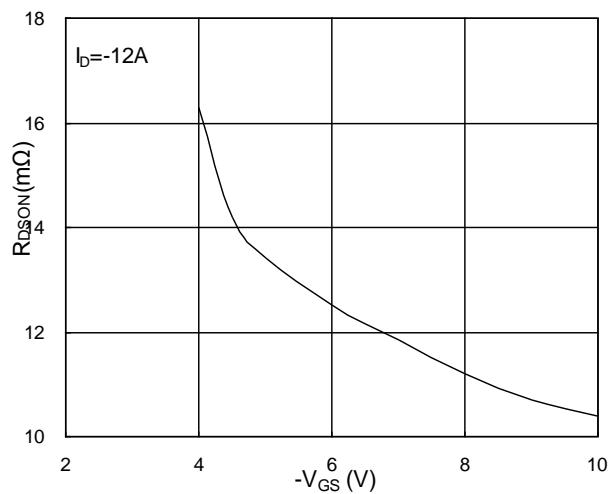


Fig.2 On-Resistance v.s Gate-Source

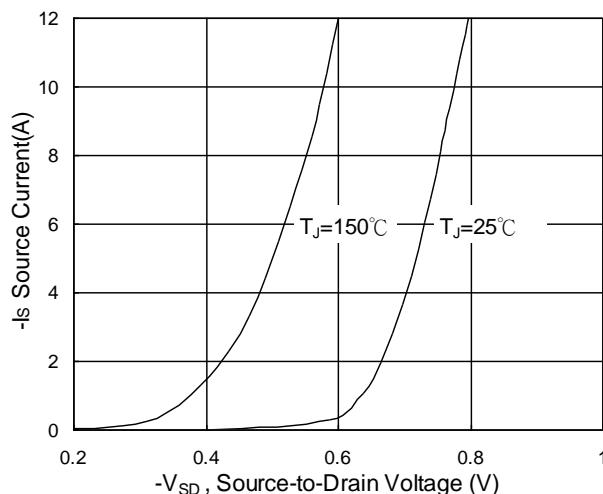


Fig.3 Forward Characteristics Of Reverse

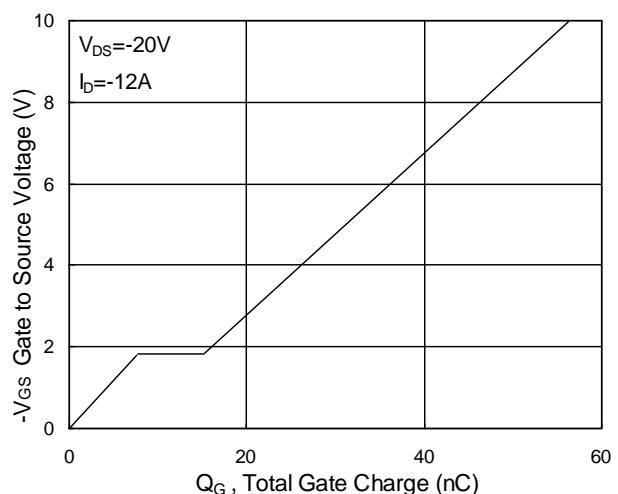


Fig.4 Gate-Charge Characteristics

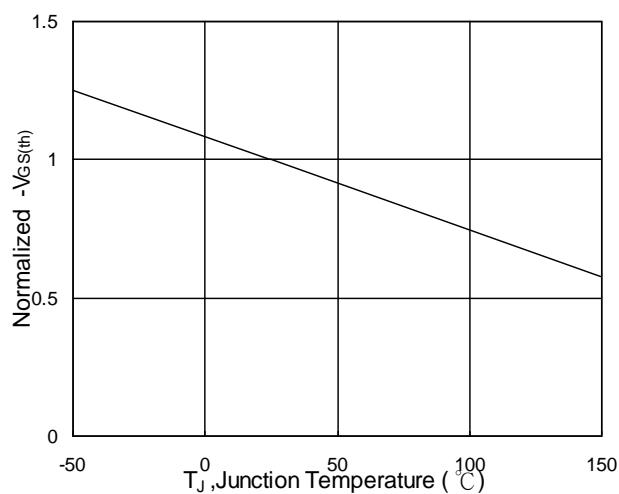


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

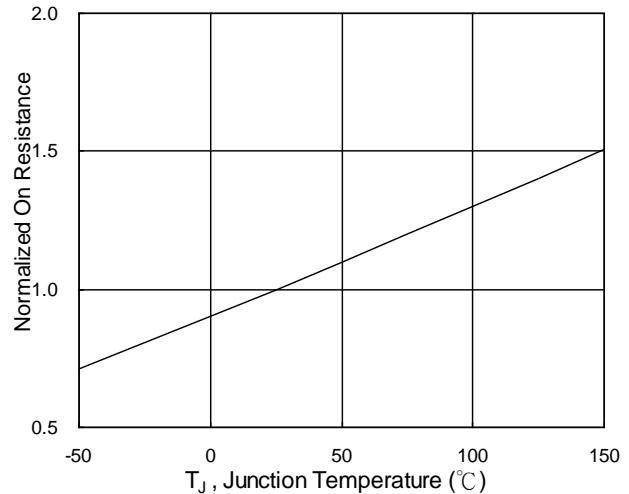
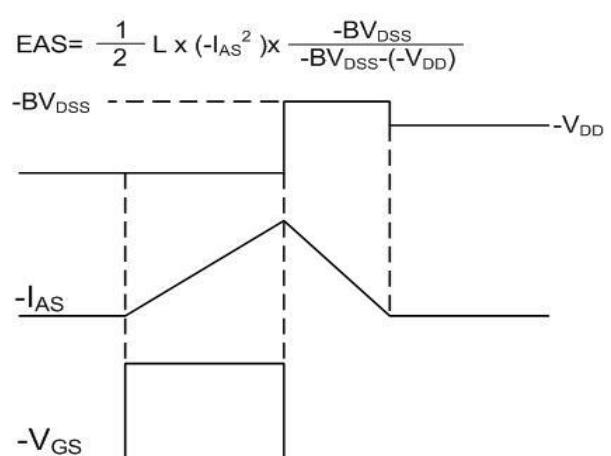
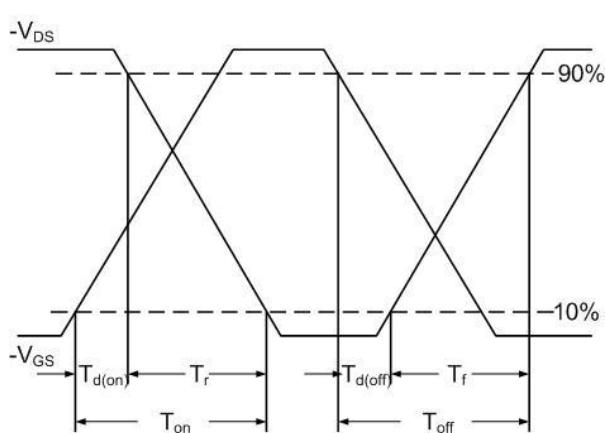
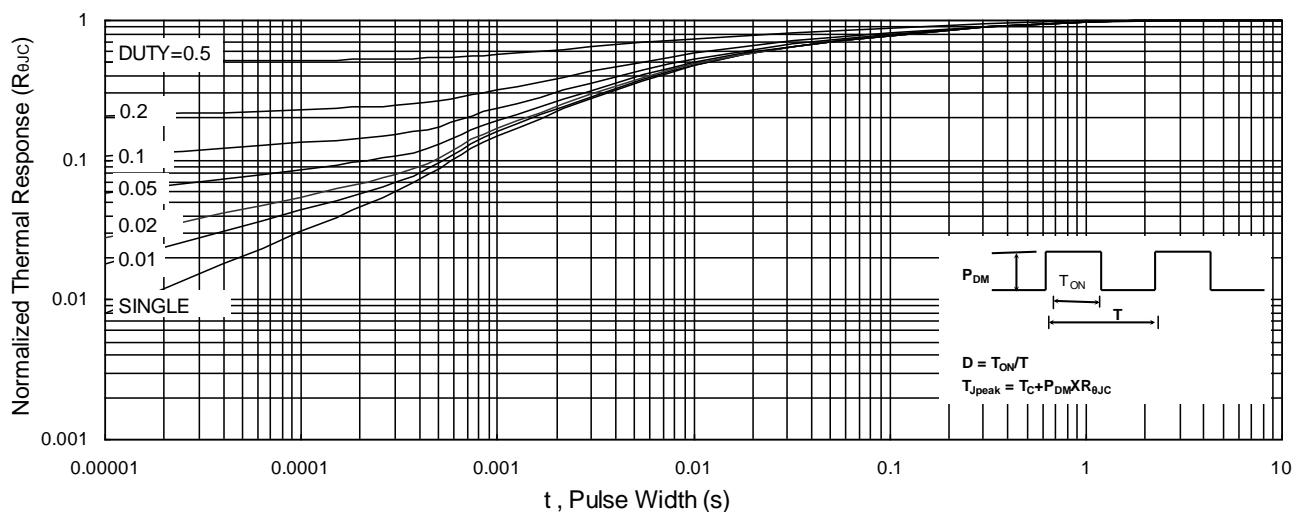
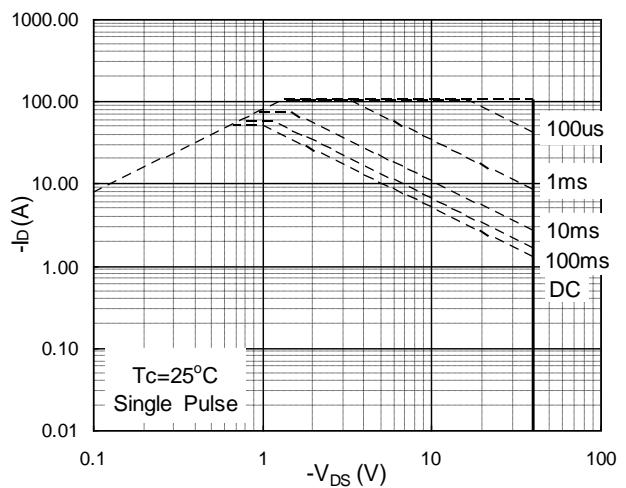
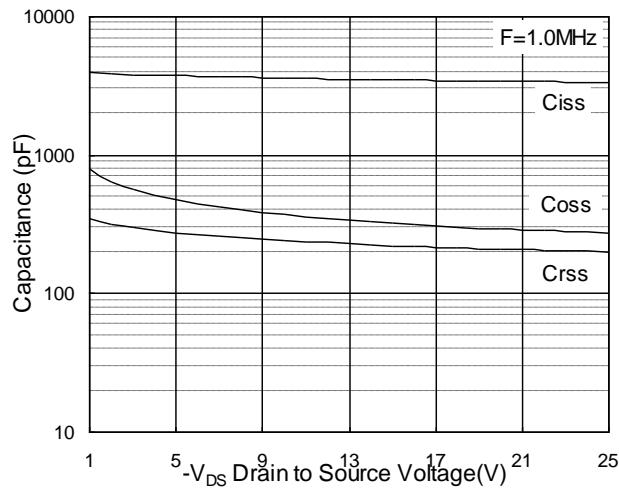
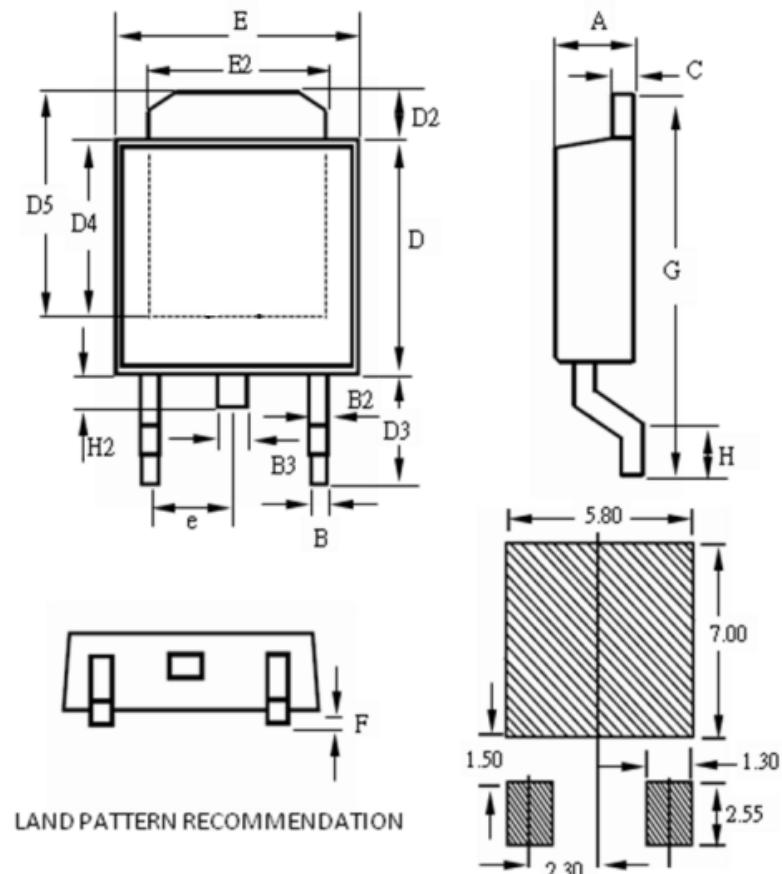


Fig.6 Normalized $R_{DS(on)}$ v.s T_J



TO-252 Package Outline



| SYMBOLS | MILLIMETERS | | | INCHES | | |
|---------|-------------|------|-------|--------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 2.10 | -- | 2.50 | 0.083 | -- | 0.098 |
| B | 0.30 | -- | 0.89 | 0.012 | -- | 0.035 |
| B2 | 0.40 | -- | 1.14 | 0.016 | -- | 0.045 |
| B3 | 0.60 | -- | 1.00 | 0.024 | -- | 0.039 |
| C | 0.40 | -- | 0.89 | 0.016 | -- | 0.035 |
| D | 5.30 | -- | 6.25 | 0.209 | -- | 0.246 |
| D2 | 0.50 | -- | 1.70 | 0.020 | -- | 0.067 |
| D3 | 2.20 | -- | 3.40 | 0.087 | -- | 0.134 |
| D4 | 4.32 | -- | -- | 0.170 | -- | -- |
| D5 | 5.21 | -- | -- | 0.205 | -- | -- |
| E | 6.30 | -- | 6.73 | 0.248 | -- | 0.265 |
| E2 | 4.80 | -- | 5.46 | 0.189 | -- | 0.215 |
| F | 0.00 | -- | 0.30 | 0.000 | -- | 0.012 |
| G | 9.20 | -- | 10.41 | 0.362 | -- | 0.410 |
| H | 0.90 | -- | 1.95 | 0.035 | -- | 0.077 |
| H2 | 0.50 | -- | 1.10 | 0.020 | -- | 0.043 |
| e | -- | 2.30 | -- | -- | 0.091 | -- |

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